

PRODUCT FEATURES

- ☐ $R_{DS(ON),typ}=0.45m\Omega@V_{GS}=10V$
- ☐ 175°C operating temperature
- ☐ Low Gate Charge Minimize Switching Loss
- ☐ Fast Recovery body Diode
- ☐ 10K Ω Gate Protected Resistance Inside
- ☐ Inside the module, each MOSFET chip has a gate resistance: 10 Ω



APPLICATIONS

- ☐ High efficiency DC/DC Converters
- ☐ Synchronous Rectifier

Type	V_{DS}	I_D	$R_{DS(ON),max}$ $T_J=25^\circ C$	T_{Jmax}	Marking	Package
MMN600DB012B	120V	600A	0.6m Ω	175 $^\circ C$	MMN600DB012B	NDB

ABSOLUTE MAXIMUM RATINGS($T_C=25^\circ C$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
V_{DSS}	Drain - Source Voltage	$T_J=25^\circ C$	120	V
V_{GSS}	Gate - Source Voltage		± 20	
I_D	Continuous Drain Current	$T_C=25^\circ C$	905	A
		$T_C=110^\circ C$	600	
I_{DM}	Pulsed Drain Current at $V_{GS}=10V$	Limited by T_{Jmax}	1200	
P_D	Maximum Power Dissipation		1500	W
E_{AS}	Single Pulse Avalanche Energy	$V_{DD}=50V, L=1mH$	7200	mJ

THERMAL AND MODULE CHARACTERISTICS ($T_C=25^\circ C$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Values	Unit
R_{thJC}	Thermal resistance, junction to case Per MOSFET		0.1	K/W
T_{Jmax}	Max. Junction Temperature		175	$^\circ C$
T_{STG}	Storage Temperature Range		-40~125	
V_{isol}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), t=1minute	3000	V
Torque	to heatsink	Recommended (M5)	2.5~5	Nm
	to terminal	Recommended (M5)	2.5~5	
Weight			240	g

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MMN600DB012B

MOSFET

ELECTRICAL CHARACTERISTICS ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain Source Breakdown Voltage	$V_{GS}=0V, I_D=2mA$	120			V
$R_{DS(ON)}$	Drain Source ON Resistance	$V_{GS}=10V, I_D=600A(\text{chip})$		0.45	0.6	m Ω
I_{DSS}	Drain Source Leakage Current	$V_{DS}=120V, V_{GS}=0V$			2	mA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=2mA$	3.0		5.0	V
I_{GSS}	Gate Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$	-2		2	mA
R_{gint}	Integrated Gate Resistor			1.5		Ω
Q_g	Total Gate Charge	$V_{DD}=60V, I_D=600A, V_{GS}=10V$		1264	1690	nC
Q_{gs}	Gate Source Charge			416		nC
Q_{gd}	Gate Drain Charge			296		nC
C_{iss}	Input Capacitance	$V_{DS}=25V, V_{GS}=0V, f=1MHz$		86		nF
C_{oss}	Output Capacitance			23.5		nF
C_{rss}	Reverse Transfer Capacitance			2.35		nF
$t_{d(on)}$	Turn on Delay Time	$V_{DD}=60V, I_D=300A, R_G=5\Omega, V_{GS}=10V, (\text{Inductive Load})$	$T_J=25^{\circ}\text{C}$	264		ns
t_r	Rise Time			200		ns
$t_{d(off)}$	Turn off Delay Time			395		ns
t_f	Fall Time			156		ns

Source-Drain BODY-DIODE CHARACTERISTICS ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter/Test Conditions		Min.	Typ.	Max.	Unit
I_{SD}	Continuous Source Drain Current				600	A
I_{SDM}	Pulse Source Drain Current	Limited by T_{Jmax}			1200	A
V_{SD}	Forward Voltage	$I_S=600A, V_{GS}=0V$		0.9	1.2	V
t_{rr}	Reverse Recovery time	$I_F=300A, V_{GS}=0V$		162		ns
Q_{RR}	Reverse Recovery Charge	$dI_F/dt=-1000A/\mu s$		6900		nC

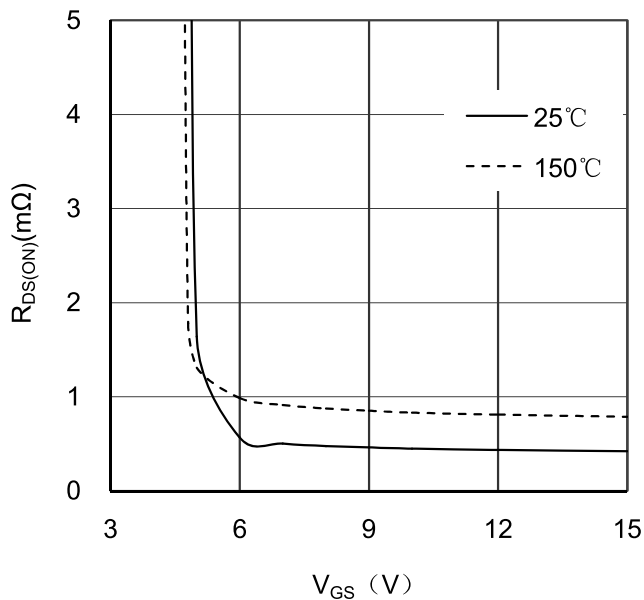
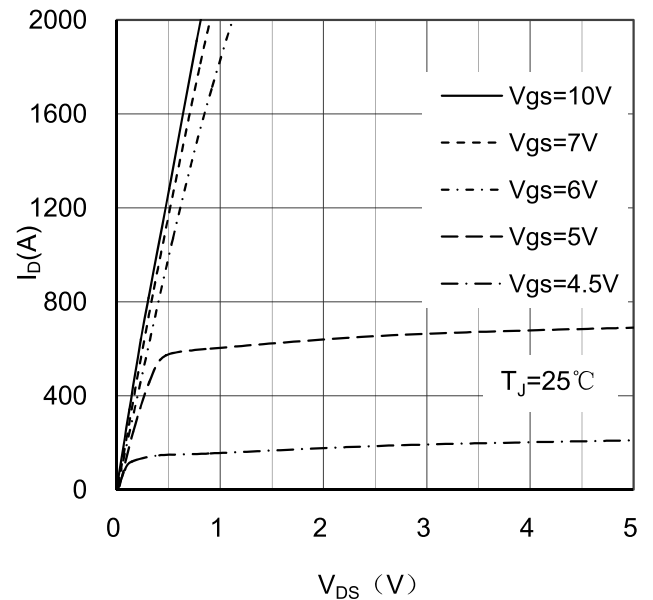
Figure 1. Typical $R_{DS(ON)}$ vs Gate Voltage

Figure 2. Typical Output Characteristics

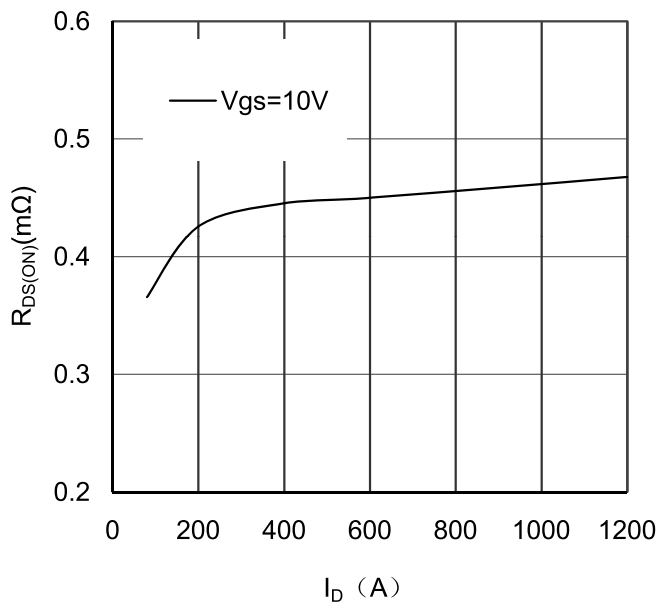
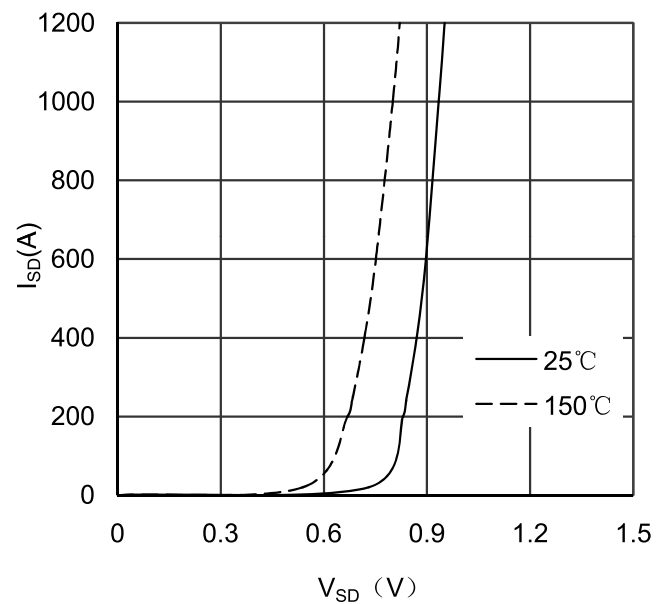
Figure 3. Drain-Source ON Resistance vs I_D 

Figure 4. Source-Drain Voltage

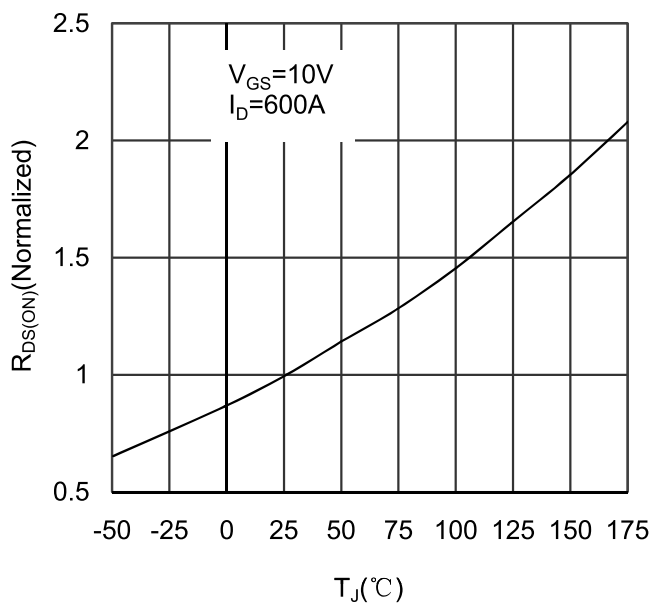


Figure 5. Drain-Source ON Resistance vs Junction Temperature

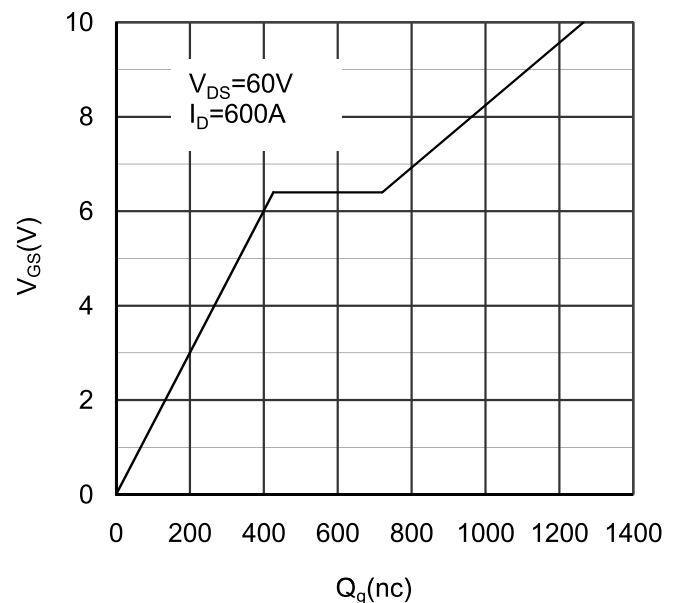


Figure 6. Gate Charge characteristics

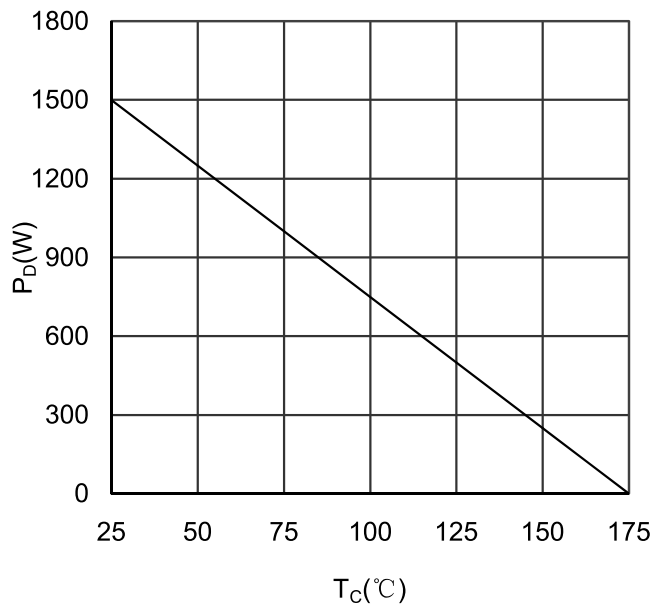


Figure 7. Maximum Power Dissipation vs Case Temperature

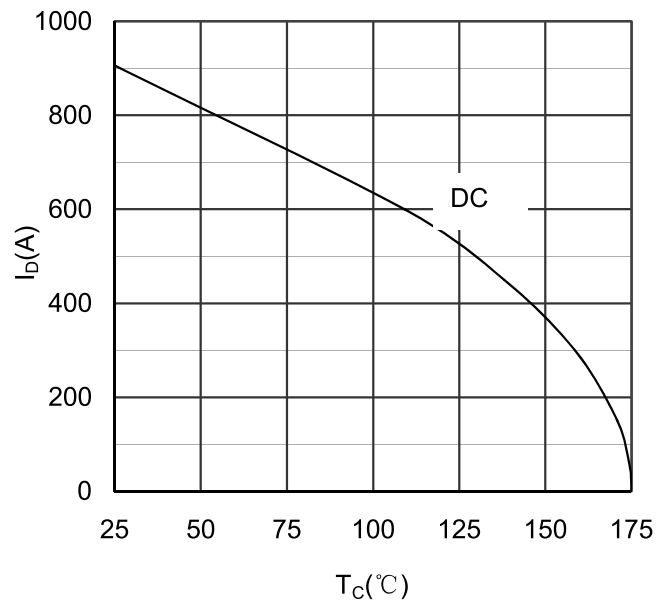


Figure 8. Maximum Continuous Drain Current vs Case Temperature

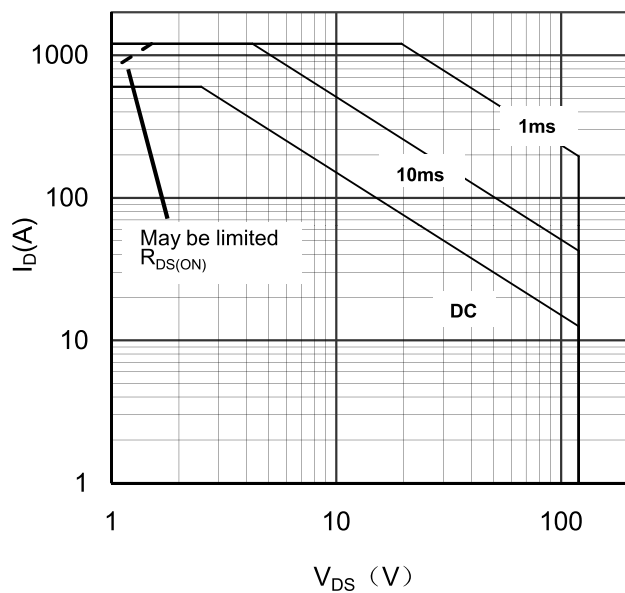


Figure 9. Maximum Forward Safe Operation Area

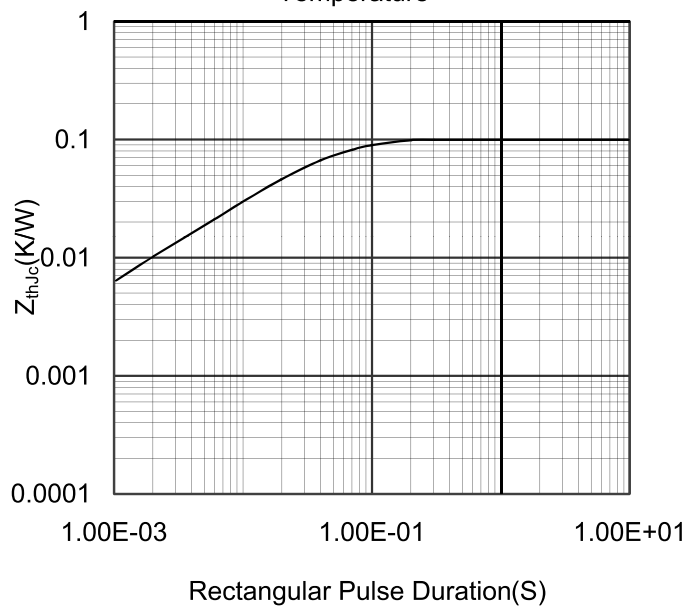


Figure 10. Transient Thermal Impedance

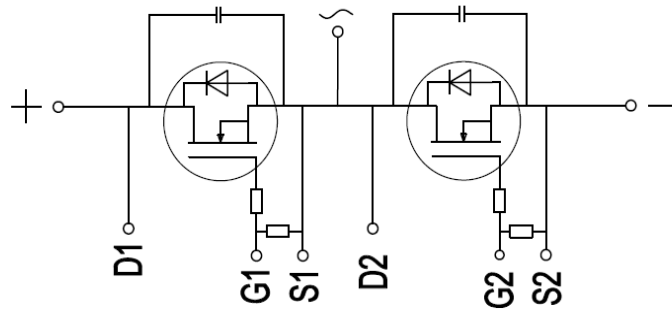


Figure 11. Circuit Diagram

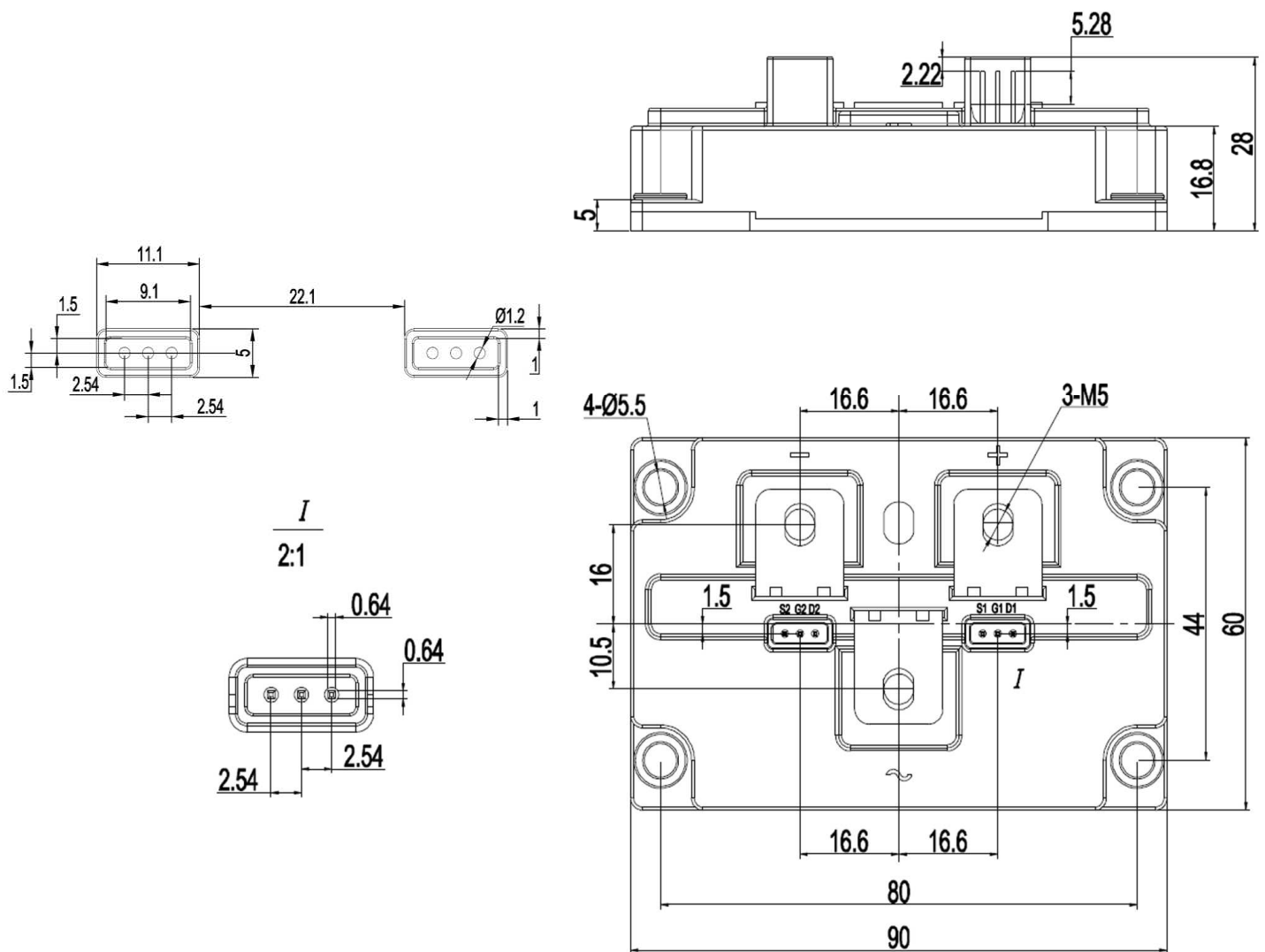


Figure 12. Package Outline